Please type a plus sign (+) inside this box → [+]

Approved for use through 10/31/2002. OMB 0651-0031

U.S. Patent and Trademark Office: U.S. DEPARTMENT OF COMMERCE

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of Information unless it contains a valid OMB control number.

bstitute for fo	m 1449A/PT	0		Complete if Known		
HEORM	ATION F	וואכו	OSUBE	Application Number	09/535,015	
STATEMENT BY APPLICANT (use as many sheets as necessary)			DICANT	Filing Date	March 24, 2000	
				First Named Inventor	Shunpei YAMAZAKI et al.	
			ssary)	Group Art Unit	2811	
				Examiner Name	S. Crane	
Sheet 1		of	1	Attorney Docket Number	0756-2131	

U.S. PATENT DOCUMENTS								
Examiner Initials	Cite No.1	U.S. Pate	ent Document	Name of Patentee or Applicant of	Date of Publication of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant		
		Number	Kind Code ² (if known)	Cited Document	MM-DD-YYYY	Figures Appear		
		<u> </u>				<u> </u>		
	ļ <u>.</u>	ļ <u></u>						
		<u> </u>						
-								
·					· · · · · · · · · · · · · · · · · · ·	 		
	-							

	, ,			F(PREIGN PATENT DOC	UMENTS		
Examiner Initials	Cite No.1	Foreign Patent Document			Name of Patentee or	Date of Publication of Cited Document	Pages, Columns, Lines, Where Relevant Passages	
		Office ³	Number ⁴	Kind Code [®] (if known)	Applicant of Cited Document	MM-DD-YYYY	or Relevant Figures Appear	T ⁰
					·			
							·	
				THER PRIOR	ART - NON PATENT LITE	RATURE DOCUMENTS		
Examiner Initials	Cite No.1	1	Include na item (book, n	me of the authonagazine, journ	or (in CAPITAL LETTERS), al, serial, symposium, cata publisher, city and/or cour	title of the article (when app log, etc.)., date, page(s), voluntry where published.	ropriate), title of the ume-issue number(s),	T²
sc		NEMANICH, R.J. et al., Structure and Growth of the Interface of Pd on a-SiH, The America Physical Society - Physical Review, Vol. 23, No. 12, Pages 6828-6831, June 1981.						

	والمناز والمنا	
Examiner	/Sara Crane/	Date 05/12/2006
Signature	/bara crane/	Considered 05/12/2006

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Signature

Approved for use through 10/31/2002. OMB 0651-0031

U.S. Patent and Trademark Office: U.S. DEPARTMENT OF COMMERCE Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number. Complete if Known Substitute for form 1449A/PTO 09/535,015 **Application Number** INFORMATION DISCLOSURE March 24, 2000 Filing Date STATEMENT BY APPLICANT Shunpei YAMAZAKI et al. First Named Inventor 🐒se as many sheets as necessary) 2811 5 8 500g **Group Art Unit** APR S. Crane **Examiner Name** PADEN FADEN **Attorney Docket Number** 0756-2131 **U.S. PATENT DOCUMENTS** U.S. Patent Document Date of Publication of Cited Pages, Columns, Lines, Where Cite No.1 Examiner Document Relevant Passages or Relevant Name of Patentee or Applicant of MM-DD-YYYY Figures Appear Cited Document Kind Code² Number FOREIGN PATENT DOCUMENTS **Date of Publication of Cited** Cite Foreign Patent Document Pages, Columns, Lines, Examiner Name of Patentee or Where Relevant Passages Document Applicant of Cited MM-DD-YYYY T⁵ Kind Code or Relevant Figures Appear Number⁴ Office³ (if known) Document OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the Examiner Cite T² item (book, magazine, journal, serial, symposium, catalog, etc.)., date, page(s), volume-issue number(s), Initials No. publisher, city and/or country where published. R.J. et al., Structure and Growth of the Interface of Pd on a-Oll I, America Physical Occiety - Physical Review, Vol. 23, No. 12, Pages 6628-6231, see I.D.S. of May 02 2006 /Sara Crane/ Date Examiner 05/12/2006

Considered

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form F20-1 (Rev. 8-83)	U.S. Departmer Patent and Tr	Attorney Docket No. 07	56-2131	Serial No. Not Yet Assigned					
NFO	RMATION DISCLOSURE STAT	EMENT	Applicant: Shunpei YAMAZAKI et al.			015			
	(Use several sheets if necessary)		Filing Date: March 24, 2000 Group: 28		Group: 2811	9/535 9/535			
	U.S	. PATENT I	DOCUMENTS						
Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date (if appropriate)			
SW7	5,403,772	04/04/95	Zhang et al						
)	5,426,064	06/20/95	Zhang et al		,				
	5,481,121	01/02/96	Zhang et al						
	5,488,000	01/30/96	Zhang et al						
	5,492,843	02/20/96	Adachi et al						
	5,501,989	03/26/96	Takayama et al						
	5,508,533	04/16/96	Takemura	\					
	5,529,937	06/25/96	Zhang et al						
	5,534,716	07/09/96	Takemura						
	5,543,352	08/06/96	Ohtani et al						
	5,563,426	10/08/96	Zhang et al						
	5,569,610	10/29/96	Zhang et al						
	5,569,936	10/29/96	Zhang et al						
	5,580,792	12/03/96	Zhang et al						
(5,585,291	12/17/96	Ohtani et al						
Sur	5,589,694	12/31/96	Takayama et al						
الاعمدار	OTHER DOCUMEN	NTS (Including	Author, Title, Date, Perti	nent Pages, I	Etc. / Sel	I.D.S. of			
AAK SIIIG	R.J. Nemanich et al, "Structure a	R.J. Nemanich et al, "Structure and Growth of the Interface of Pd on a-SiH", The American Physical No. 3 Society - Physical Review, Vol. 22, No. 12, pp. 6828-6831, June 1981							
Suc	M.J. Thompson et al, "Silicide Fo	M.J. Thompson et al, "Silicide Formation in Pd-α-Si:H Schottky Barriers", Appl. Phys. Lett., Vol. 39, No. 3,							
546		Hayashi et al., "Fabrication of Low-Temperature Bottom-Gate Poly-Si TFTs on Large-Area Substrate by Linear-Beam Excimer Laser Crystallization and Ion Doping Method", IEEE IEDM 1995, pages 829-832.							
Suc	R.J. Nemanich et al, "Initial Phase Formation at the Interface of Ni, Pd, or Pt and Si", Mat. Res. Soc. Symp. Proc., Vol. 25, 1984								
Examiner	CRANC		Date Considered	10/18/10)5				
*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									